PSMN1R1-40BS



N-channel 40 V 1.4 m Ω standard level MOSFET in D2PAK Rev. 1 — 29 September 2011 Objective data

Objective data sheet

Product profile 1.

1.1 General description

Standard level N-channel MOSFET in D2PAK (SOT404) package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

1.3 Applications

- DC-to-DC convertors
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-------------------|----------------------------------|---|-----|------|-----|------|
| V_{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | - | - | 40 | V |
| I _D | drain current | T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> | - | - | 120 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | - | - | 306 | W |
| Tj | junction temperature | | -55 | - | 175 | °C |
| Static char | acteristics | | | | | |
| R _{DSon} | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 100 \text{ °C}; \text{ see } \frac{\text{Figure 12}}{\text{see } \frac{\text{Figure 13}}{\text{Figure 13}}}$ | - | 1.68 | 2 | mΩ |
| | | $V_{GS} = 10 \text{ V; } I_D = 25 \text{ A;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure } 13}{\text{ Figure } 13}$ | - | 1.16 | 1.4 | mΩ |



Table 1. Quick reference data ...continued

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|--|--|-----|-----|-----|------|
| Dynamic o | characteristics | | | | | |
| Q_{GD} | gate-drain charge | $V_{GS} = 10 \text{ V}; I_D = 75 \text{ A};$ | - | 32 | - | nC |
| Q _{G(tot)} | total gate charge | V _{DS} = 20 V; see <u>Figure 14;</u> see <u>Figure 15</u> | - | 136 | - | nC |
| Avalanche | ruggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 120 A; $V_{sup} \le$ 40 V; unclamped; R_{GS} = 50 Ω ; t_p = 0.1 ms | - | - | 1.4 | J |

^[1] Continuous current is limited by package

2. Pinning information

Table 2. Pinning information

| | • | | | |
|-----|--------|----------------------|--------------------|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | G | gate | | _ |
| 2 | D | drain ^[1] | mb | B |
| 3 | S | source | | |
| mb | D | drain | | |
| | | | | mbb076 S |
| | | | 1 3 | |
| | | | SOT404 (D2PAK) | |
| | | | | |

^[1] It is not possible to make connection to pin 2

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|--------------|---------|--|---------|
| | Name | Description | Version |
| PSMN1R1-40BS | D2PAK | plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped) | SOT404 |

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| | | , | | | | |
|----------------------|--|---|-----|-----|------|------|
| Symbol | Parameter | Conditions | | Min | Max | Unit |
| V_{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | | - | 40 | V |
| V_{DGR} | drain-gate voltage | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$ | | - | 40 | V |
| V_{GS} | gate-source voltage | | | -20 | 20 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 100 °C | [1] | - | 120 | Α |
| | | $V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{M}}$ | [1] | - | 120 | Α |
| I _{DM} | peak drain current | pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$; see Figure 3 | | - | 1320 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | | - | 306 | W |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| Tj | junction temperature | | | -55 | 175 | °C |
| $T_{sld(M)}$ | peak soldering temperature | | | - | 260 | °C |
| Source-dra | ain diode | | | | | |
| I _S | source current | T _{mb} = 25 °C | [1] | - | 120 | Α |
| I _{SM} | peak source current | pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$ | | - | 1320 | Α |
| Avalanche | ruggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 120 A; $V_{sup} \le$ 40 V; unclamped; R_{GS} = 50 Ω ; t_p = 0.1 ms | | - | 1.4 | J |

[1] Continuous current is limited by package

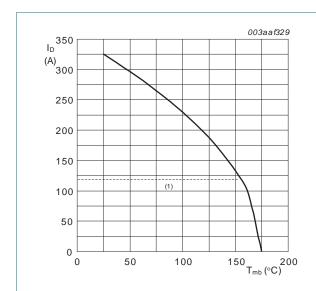


Fig 1. Normalized continuous drain current as a function of mounting base temperature

 $V_{GS} \ge 10 \text{ V}$; (1) Capped at 120 A due to package

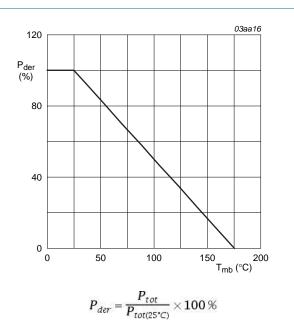
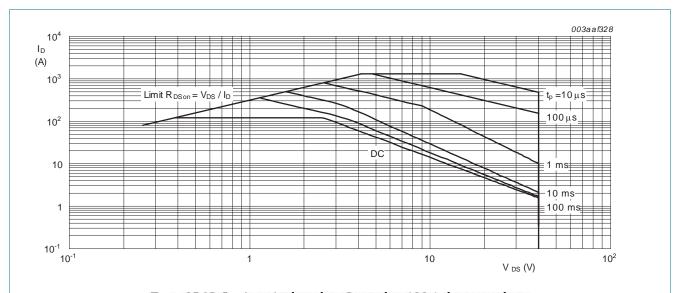


Fig 2. Normalized total power dissipation as a function of mounting base temperature



 T_{mb} = 25 °C; I_{DM} is a single pulse; Capped at 120 A due to package

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|---|-----|------|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | - | 0.22 | 0.49 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | minimum footprint; mounted on a printed-circuit board | - | 50 | - | K/W |

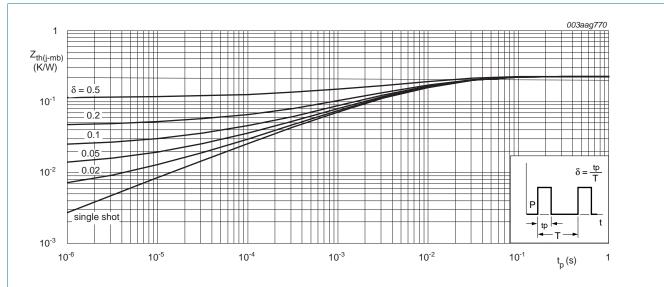


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

| Table 0. | | | | _ | | |
|------------------------|-----------------------------------|---|-----|------|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| | aracteristics | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$ | 36 | - | - | V |
| | voltage | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$ | 40 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see <u>Figure 10</u> | - | - | 4.6 | V |
| | | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see <u>Figure 10</u> | 1 | - | - | V |
| | | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 11</u> ; see <u>Figure 10</u> | 2 | 3 | 4 | V |
| I _{DSS} | drain leakage current | V _{DS} = 40 V; V _{GS} = 0 V; T _j = 25 °C | - | 0.02 | 10 | μA |
| | | V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C | - | - | 500 | μA |
| I _{GSS} | gate leakage current | V _{GS} = 20 V; V _{DS} = 0 V; T _j = 25 °C | - | 10 | 100 | nA |
| | | V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C | - | 10 | 100 | nA |
| R _{DSon} | drain-source on-state resistance | V_{GS} = 10 V; I_D = 25 A; T_j = 100 °C; see <u>Figure 12</u> ; see <u>Figure 13</u> | - | 1.68 | 2 | mΩ |
| | | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 °C;$ see Figure 12; see Figure 13 | - | 2.3 | 2.8 | mΩ |
| | | $V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C;}$ see Figure 13 | - | 1.16 | 1.4 | mΩ |
| R _G | internal gate resistance (AC) | f = 1 MHz | - | 1.1 | - | Ω |
| Dynamic | characteristics | | | | | |
| Q _{G(tot)} | total gate charge | $I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$ | - | 133 | - | nC |
| | | $I_D = 75 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V}; \text{see}$ | - | 136 | - | nC |
| Q _{GS} | gate-source charge | Figure 14; see Figure 15 | - | 52 | - | nC |
| Q _{GS(th)} | pre-threshold gate-source charge | | - | 30 | - | nC |
| Q _{GS(th-pl)} | post-threshold gate-source charge | | - | 22 | - | nC |
| Q_{GD} | gate-drain charge | | - | 32 | - | nC |
| $V_{GS(pI)}$ | gate-source plateau voltage | $I_D = 75 \text{ A}$; $V_{DS} = 20 \text{ V}$; see <u>Figure 14</u> ; see <u>Figure 15</u> | - | 6.1 | - | V |
| C _{iss} | input capacitance | V _{DS} = 20 V; V _{GS} = 0 V; f = 1 MHz; | - | 9710 | - | pF |
| C _{oss} | output capacitance | T _j = 25 °C; see <u>Figure 16</u> | - | 2042 | - | pF |
| C _{rss} | reverse transfer capacitance | | - | 994 | - | pF |
| t _{d(on)} | turn-on delay time | $V_{DS} = 20 \text{ V}; R_L = 0.8 \Omega; V_{GS} = 5 \text{ V};$ | - | 45 | - | ns |
| t _r | rise time | $R_{G(ext)} = 4.7 \Omega$ | - | 66 | - | ns |
| t _{d(off)} | turn-off delay time | | - | 111 | - | ns |
| t _f | fall time | | - | 53 | - | ns |
| | | | | | | |

Table 6. Characteristics ... continued

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------|-----------------------|---|-----|-----|-----|------|
| Source-drain diode | | | | | | |
| V _{SD} | source-drain voltage | $I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 17 | - | 0.8 | 1.2 | V |
| t _{rr} | reverse recovery time | $I_S = 25 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; | - | 64 | - | ns |
| Q _r | recovered charge | $V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}$ | - | 117 | - | nC |

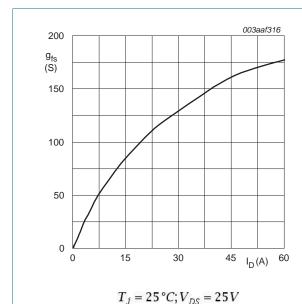


Fig 5. Forward transconductance as a function of

drain current; typical values

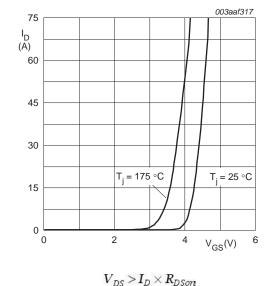


Fig 6. Transfer characteristics: drain current as a

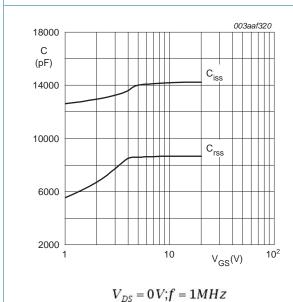


Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

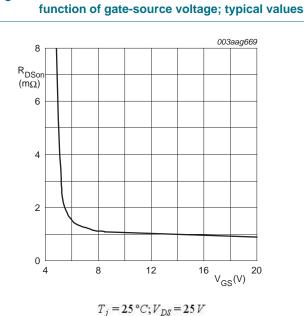


Fig 8. Drain-source on-state resistance as a function of gate-source voltage; typical values.

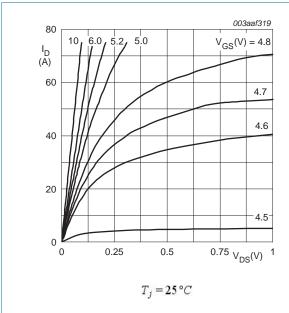


Fig 9. Output characteristics: drain current as a function of drain-source voltage; typical values

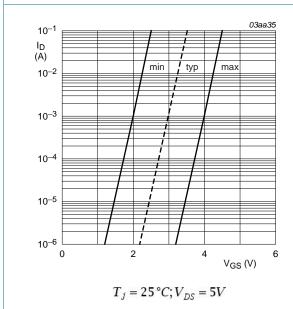


Fig 11. Sub-threshold drain current as a function of gate-source voltage

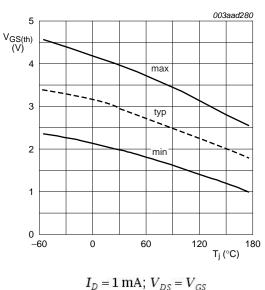


Fig 10. Gate-source threshold voltage as a function of junction temperature

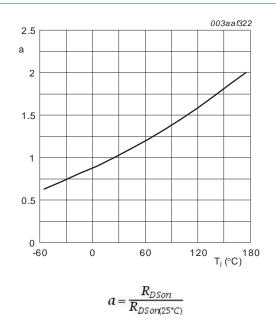
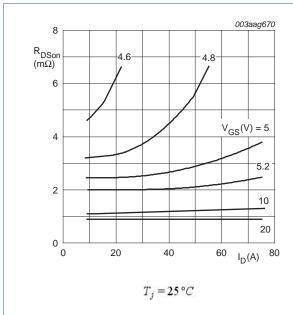


Fig 12. Normalized drain-source on state resistance factor as a function of junction temperature



V_{DS}

V_{GS(pl)}

V_{GS(th)}

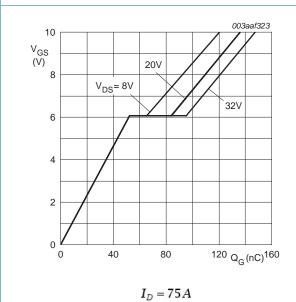
V_{GS}

Q_{GS1}
Q_{GS2}
Q_G(tot)

003aaa508

Fig 13. Drain-source on-state resistance as a function of drain current; typical values

Fig 14. Gate charge waveform definitions



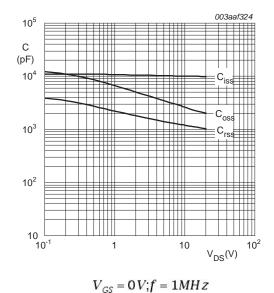
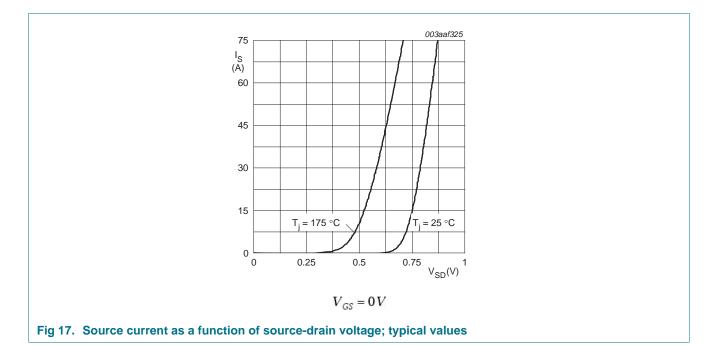


Fig 15. Gate-source voltage as a function of gate charge; typical values





7. Package outline

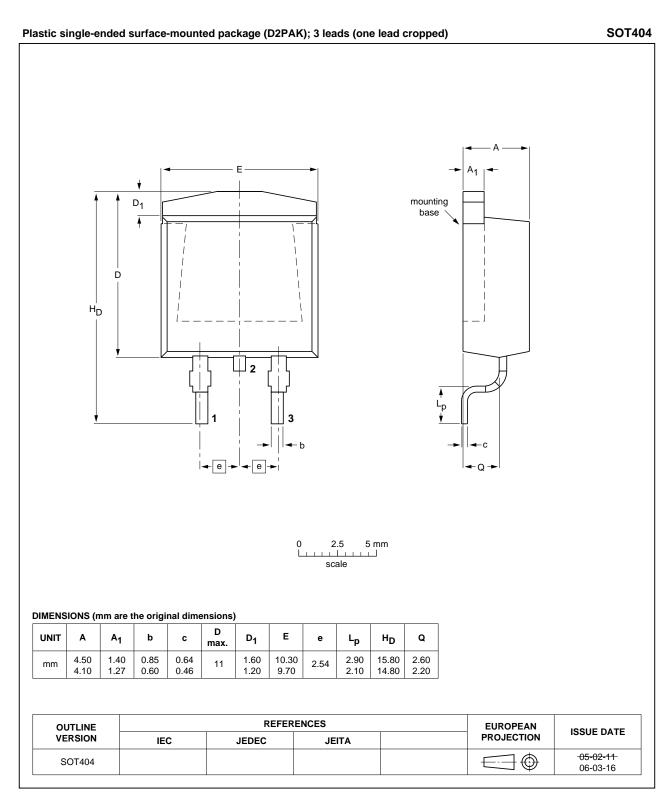


Fig 18. Package outline SOT404 (D2PAK)

8. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|------------------|--------------|----------------------|---------------|------------|
| PSMN1R1-40BS v.1 | 20110929 | Objective data sheet | - | - |

9. Legal information

9.1 Data sheet status

| Document status [1] [2] | Product status [3] | Definition |
|--------------------------------|--------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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| Product [short] data sheet | Production | This document contains the product specification. |

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- [2] The term 'short data sheet' is explained in section "Definitions'
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PSMN1R1-40BS

PSMN1R1-40BS

N-channel 40 V 1.4 mΩ standard level MOSFET in D2PAK

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